SN54HC365 THRU SN54HC368 SN74HC365 THRU SN74HC368 HEX BUS DRIVERS WITH 3-STATE OUTPUTS

SCLS139 D2684, DECEMBER 1982-REVISED JUNE 1989

- High-Current 3-State Outputs Drive Bus Lines, Buffer Memory Address Registers, or Up to 15 LSTTL Loads
- Choice of True or Inverting Outputs
- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil
- Dependable Texas Instruments Quality and Reliability

'HC365, HC367 'HC366, HC368

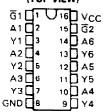
True Outputs Inverting Outputs

description

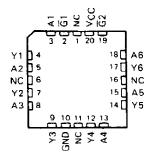
These Hex buffers and line drivers are designed specifically to improve both the performance and density of three-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. The designer has a choice of selected combinations of inverting and noninverting outputs, symmetrical G (active-low control) inputs.

The SN54HC' family is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74HC' family is characterized for operation from -40°C to 85°C.

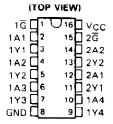
SN54HC365, SN54HC366 . . . J PACKAGE SN74HC366, SN74HC366 . . . D^{\dagger} OR N PACKAGE (TOP VIEW)



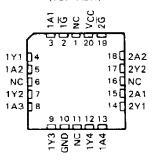
SN54HC365, SN54HC366 . . . FK PACKAGE (TOP VIEW)



SN54HC367, SN54HC368 . . . J PACKAGE SN74HC367, SN74HC368 . . . D[†] OR N PACKAGE



SN54HC367, SN54HC368 . . . FK PACKAGE (TOP VIEW)

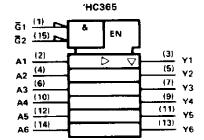


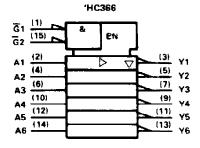
NC-No internal connection

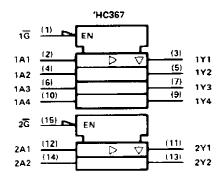
INSTRUMENTS

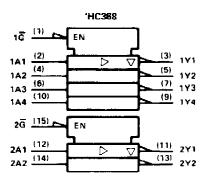
[†] Contact the factory for D availability.

logic symbols†

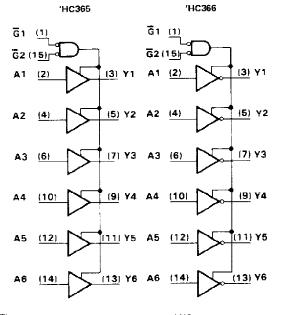


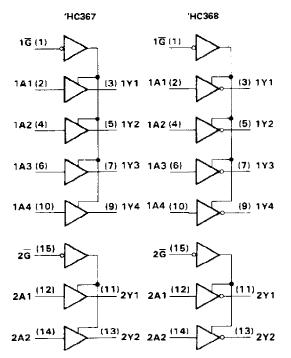






logic diagrams (positive logic)





[†]These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, and N packages.

absolute maximum ratings over operating free-air temperature range†

Supply voltage, VCC	-0.5 V to 7 V
Input clamp current, IIK (VI < 0 or VI > VCC)	
Output clamp current, IOK (VO < 0 or VO > VCC)	± 20 mA
Continuous output current, IO (VO = 0 to VCC)	±35 mA
Continuous current through VCC or GND pins	± 70 mA
Lead temperature 1,6 mm (1/16 in) from case for 60 s: FK or J package	
Lead temperature 1,6 mm (1/16 in) from case for 10 s: D or N package	260°C
Storage temperature range	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

				SN54HC365 thru SN54HC368		SN74HC365 thru SN74HC368			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC} Supply voltage			2	5	6	2	5	6	>
		V _{CC} = 2 V	1.5			1.5			
VIH High-level input voltage	High-level input voltage	V _{CC} = 4.5 V	3.15			3.15			٧
		VCC = 6 V	4.2			4.2			
		V _{CC} = 2 V	0		0.3	0		0.3	
VIL	Low-level input voltage	V _{CC} = 4.5 V	0		0.9	0		0.9	v
		Vcc = 6 V	0		1.2	0		1.2	
٧ı	Input voltage		0		Vсс	0		Vсс	>
۷o	Output voltage		0		Vcc	0		Vac	>
		V _{CC} = 2 V	0		1000	0		1000	
t _t Input transition (rise	input transition (rise and fall) times	V _{CC} = 4.5 V	0		500	0		500	r.s
		VCC = 6 V	0		400	0		400	
ŤΑ	Operating free-air temperature		- 55		125	-40		85	°C

SN54HC365 THRU SN54HC368 SN74HC365 THRU SN74HC368 HEX BUS DRIVERS WITH 3-STATE OUTPUTS

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	vcc	TA - 25°C		SN54HC366 thru SN54HC368		SN74HC365 thru SN74HC368		UNIT
			MIN TYP	MAX	MIN	MAX	MIN	MAX	ĺ
		2 V	1.9 1.998	3	1.9		1.9		
	$V_{I} = V_{IH} \text{ or } V_{IL}, I_{OH} = -20 \mu A$	4.5 V	4.4 4.499	•	4.4		4.4		
VoH		6 V	5.9 5.999)	5.9		5.9		٧
-	V _I ≈ V _{IH} or V _{IL} , l _{OH} ≂ −6 mA	4.5 V	3.98 4.30)	3.7		3.84		
	$V_I = V_{IH}$ or V_{IL} , $I_{OH} = -7.8$ mA	6 V	5.48 5.80)	5.2		5.34		
		2 V	0.002	0.1		0.1		0.1	
	V _I = V _{IH} or V _{IL} , I _{OL} = 20 μA	4.5 V	0.001	0.1		0.1		0.1	
VOL	_	6 V	0.001	0.1		0.1		0.1	V
	VI ≈ VIH or VIL, IOL = 6 mA	4.5 V	0.17	0.26		0.4		0.33	
	V _I = V _{IH} or V _{IL} , I _{OL} = 7.8 mA	6 V	0.15	0.26		0.4		0.33	
ų	V _I = VCC or 0	6 V	±0.1	± 100		± 1000		± 1000	nA
loz	Vo = Vcc or 0	6	± 0.01	±0.5		±10		± 5	μА
lcc .	V _I ≈ V _{CC} or 0, I _O = 0	6 V		8		160	_	80	μА
Ci		2 to 6 V	3	10	_	10		10	pF

switching characteristics over recommended operating free-air temperature range (unless otherwise noted), $C_L = 50$ pF (see Note 1)

PARAMETER	CDOSC (INDICT)	FROM (INPUT) TO (OUTPUT)	V	TA = 25°C		SN54HC'	SN74HC	T
	FROM (INPUT)	10 (001201)	Vcc	MIN TYP	MAX	MIN MAX	MIN MAX	UNIT
. 1			2 V	50	95	145	120	
t _{pd} A	Y	4.5 V	12	19	29	24	ns	
, i			6 V	10	16	25	20	ļ
			2 V	100	190	285	238	
ten	G	র Y	4.5 V	26	38	57	48	ns
			6 V	21	32	48	41	
			2 V	50	175	265	240	
[†] dis	\overline{G}	Y	4.5 V	21	35	53	48	ns
			6 V	19	30	45	41	
			2 V	28	60	90	75	
tt		Any	4.5 ∨	8	12	18	15	ns
			6 V	6	10	15	13	

Cpd	Power dissipation capacitance per driver	No load, TA = 25°C	35 pF tγp

switching characteristics over recommended operating free-air temperature range (unless otherwise noted), $C_L = 150 \text{ pF}$ (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	٧cc	TA - 25°C		SN54HC'		SN74HC'		
				MIN TYP	MAX	MIN M	AX	MIN	MAX	UNIT
			2 V	70	120		BO		150	
t _{pd}	Α	Y	4.5 V	17	24		36		30	ns
			6 V	14	20		31		25	
			2 V	140	230	:	345		285	
ten	₫	Y	4.5 V	30	46		69		57	ns
			6 V	28	39		59		48	
			2 V	45	210	3	315		265	
tt			4.5 V	17	42		63		53	ns
			6 V	13	36		53		45	

NOTE 1: Load circuit and voltage waveforms are shown in Section 1.

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